# AN14003

# Programming the KW45 flash for Application and Radio firmware via Serial Wire Debug during mass production

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**Application note** 

## **Document information**

Information	Content
Keywords	AN14003, KW45 processor, KW45B41Z board, fuse programming, burning CM33 and NBU firmware, mass production, keys preparation, debug authentication, J-Link, Secure Provisioning Software Development Kit (SPSDK)
Abstract	This application note describes an efficient method to merge programming the KW45 fuse, burning CM33 and NBU firmware operations into one binary file during mass production. It also describes a method for debug authentication.



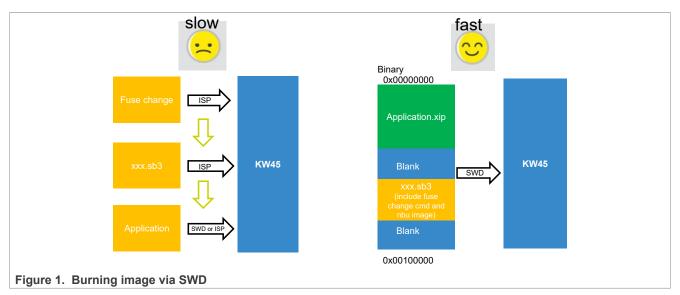
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# 1 Introduction

KW45 is a three-core platform that integrates a Cortex-M33 application core (CM33), a dedicated Cortex-M3 radio core, and an isolated EdgeLock Secure Enclave. The radio core, also called as Narrow Band Unit (NBU) features a Bluetooth Low Energy (LE) unit with a dedicated flash. The memories integrated in the NBU consist of Bluetooth LE controller stack and radio drivers.

On KW45, only boot ROM has access to the NBU flash. The ROM bootloader provides an in-system programming (ISP) utility that operates over a serial connection on the microcontroller units (MCUs).

The speed of programming the image using ISP is relatively slower than SWD. During the mass production of KW45, it is necessary to program the fuse first, download the NBU firmware and finally download the CM33 firmware. This document describes a method, which merges the fuse programming and burning CM33 and NBU firmware operations to produce a single binary file. The method increases the production efficiency as it requires downloading the merged binary file only once through Serial Wire Debug (SWD). The document also describes a method to write the RoTKTH and SB3KDK fuse keys to a KW45B41Z board in which these keys are null.



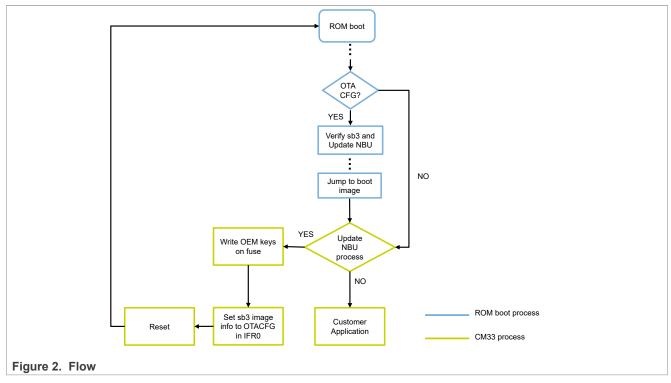
**Note:** The method of burning the fuse provided in this document cannot be reversed. The keys programmed to fuses on KW45 cannot be changed anymore. Therefore, it is recommended to modify the fuse with caution.

# 2 Prerequisites

A basic understanding of the boot process of ROM boot and security is required for implementing the steps described in this document. For more details, refer to KW45 Reference Manual, see Section 8.

In brief, the process implements fuse programming and updates NBU in the CM33 image. Then the CM33 image and NBU image are merged to a single image. After downloading merged image to KW45 flash of CM33 via SWD, fuse programming is done first and then the image is burnt to NBU. The flow is shown in Section 2.

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There are two limitations for the method:

- The flash size of CM33 core should be enough for application + .sb3 file.
- Lifecycle of KW45 should be in OEM-OPEN state.

# 3 Debug session initiation

The method to initiate a debug session varies depending on the device state and intended debug scenario.

- For a lifecycle that does not require debug authentication, the debug session can be initiated without performing debug authentication.
- For a lifecycle that requires debug authentication, debug session can be initiated only after debug authentication.

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# 4 OEM keys and certificate preparation by SPSDK

This section describes the steps for preparing OEM keys and certificate preparation using SPSDK.

# 4.1 Setting up the SPSDK environment

Secure Provisioning SDK (SPSDK) is an open source python SDK library with its source code released on <u>Github</u> and <u>PyPI</u>. It provides a set of API modules for custom production tool development, which requires more advanced secure provisioning flow. This document uses Windows system as example.

For more details, refer to SPSDK user guide on: https://spsdk.readthedocs.io/en/latest/index.html.

- 1. Install Python 3.7+ on a personal laptop.
- 2. Open the command prompt (cmd.exe). Then, run the following commands to install SPSDK:

```
python -m venv venv

venv\Scripts\activate
python -m pip install --upgrade pip
pip install spsdk
```

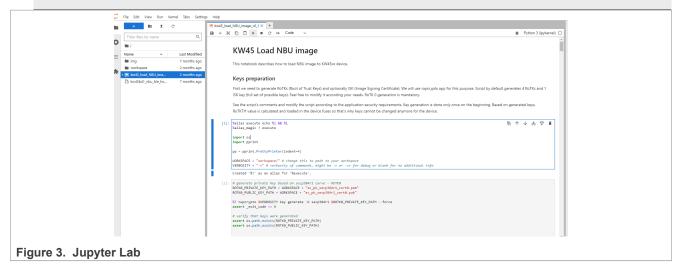
- 3. The above commands create a virtual environment on the user's laptop. Then install SPSDK also includes dependence file on the virtual environment.
- 4. Jupyter Lab is a web-based interactive development environment. NXP provides examples based on Jupyter Notebook as an easy interactive tool for user, on above virtual environment install Jupyter Lab by using the command:

```
pip install jupyterlab
```

Jupyter Notebook examples are also provided as interactive documentation. For users with no experience with the Jupyter environment, reading the tutorial available at the below URL is recommended: <a href="https://docs.jupyter.org/en/latest/start/index.html">https://docs.jupyter.org/en/latest/start/index.html</a>

- 5. KW45 Jupyter notebook example file is located in path where SPSDK is released on Github.
  - This path is: spsdk/<u>examples</u>/jupyter examples/kw45xx k32w1xx/
  - The file extension is .ipynb, download it to personal laptop.
- 6. In the virtual environment, launch the Jupyter Lab using the command below:

```
cd C:\path of store Jupyter notebook example.ipynb
jupyter-lab
```



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Each section of Jupyter Notebook example contains an executable field and descriptions. To execute a field, select it and then click the **Execute** button in top menu icon of the window. Refer <u>Figure 3</u>.

# 4.2 Preparing the keys and certificate

Two types of keys must be written to KW45 fuse during mass production. In a factory chip, the keys in the fuse are null. These keys are listed below:

- RoTKTH (CUST PROD OEMFW AUTH PUK): Four Roots of Trust Key pairs (RoTK) generate this key.
- SB3KDK (CUST PROD OEMFW ENC SK): It is an Advanced Encryption Standard (AES) key.

#### **CAUTION:**

The fuse is a program-once region. If the RoTKTH and SB3KDK keys are not written to fuse or the incorrect keys are written to the firmware, then the method described in this document would fail.

By default, RoTKTH and SB3KDK are provided for KW45B41Z-EVK board. This document describes a method to write these default keys to a KW45B41Z board in which these keys in fuse are null. For more details on how RoTKTH and SB3KDK can be generated and how these keys are used for secure boot, refer to 'Secure Boot for KW45 and K32W (AN13838). See Section 8.

To execute the code to generate new keys, follow the description in the Jupyter Notebook example. Users can change the WORKSPACE as per the actual keys and certificate files storage path, set VERBOSITY as '-v' to observe the debug and additional information. Refer to Figure 4.

If you want to use existing keys and/or certificate, then execute the first executable field, skip executing the keys preparation, certificate preparation, and generate the SB3KDK code. Then, change the keys and certificate path as shown in Section 5.1.

The RoTKTH and SB3KDK keys can be observed during Sb3.1 generation when VERBOSITY is set to "-v" as shown in Figure 5.

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# 5 Mass processing and image preparation

## 5.1 NBU image preparation

NBU firmware file (.xip) is provided in the SDK path:

SDK store path\middleware\wireless\ble controller\bin\

**Note:** If the user burns fuse using EVK default keys, the .sb3 file located in above path could be used. Otherwise, the .xip file should be used for generating customer .sb3 file first.

## 5.1.1 SB3 file generation

Sb3 file can be generated by executing the "*Prepare SB3.1 configuration file*" code in the Jupyter Notebook example. For this purpose, provide the following in the field as shown in <u>Figure 6</u>:

- The path of the keys (SB3KDK KEY PATH, ROTKO PRIVATE KEY PATH)
- The certificate path (ROOT\_0\_CERT\_PATH, ROOT\_1\_CERT\_PATH, ROOT\_2\_CERT\_PATH, ROOT\_3\_CERT\_PATH) The path is defined and filled to the above parameters if the user executes all executable fields on the Jupyter notebook example.

In order to use the existing keys and/or certificate, you should define the path of existing keys and/or certificate in the above parameters.

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```
[7]: SB31_FILE_PATH = "sb3.sb3"
                     import yaml
                     assert os.path.exists(SB31 TEMPLATE PATH)
                     # Create configuration for sb31
                     with open(SB31 TEMPLATE PATH) as sb31 config:
                         # load yaml configuration to dictionary
                         sb31 = yaml.safe_load(sb31_config)
                         # change paths
                         sb31['containerOutputFile'] = SB31_FILE_PATH
                         sb31['containerKeyBlobEncryptionKey'] = SB3KDK KEY PATH
                         sb31['description'] = "384_none_nbu_only"
                         sb31['kdkAccessRights'] = 3
                         sb31['containerConfigurationWord'] = 0
                         sb31['rootCertificate@File'] = ROOT_@_CERT_PATH
                         sb31['rootCertificate1File'] = ROOT 1 CERT PATH
                         sb31['rootCertificate2File'] = ROOT_2_CERT_PATH
                         sb31['rootCertificate3File'] = ROOT_3_CERT_PATH
                         sb31['mainRootCertId'] = 0
                         sb31['mainRootCertPrivateKeyFile'] = ROTK0_PRIVATE_KEY_PATH
                         sb31['rootCertificateEllipticCurve'] = "secp384r1"
                         sb31['useIsk'] = False
                         del sb31['signingCertificatePrivateKeyFile']
                         del sb31['signingCertificateFile']
                         del sb31['signCertData']
del sb31['commands']
                         del sb31['iskCertificateEllipticCurve']
                         sb31['commands'] = [
                                  "erase": {
                                      "address": "0x48800000 ",
                                      "size": "0x30000"
                             },
                                  "load": {
                                      "address": "0x48800000 ",
                                      "file": "kw45b41_nbu_ble_hosted_04.xip"
                             }
                         ]
                     with open(SB31_TEMPLATE_PATH, "w+") as sb31_config:
Figure 6. sb3 file generation configuration
```

### 5.1.2 Changing the lifecycle (optional)

The KW45 lifecycle can be changed by adding programFuse command in SB3 file generation code (refer to Figure 7). However, If you do not want to change the lifecycle, then do not add this command.

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- In case the board lifecycle is changed to an after OEM-OPEN state (for example, ... 0x0F) by adding the programFuse command the secure boot is enabled after update of NBU. This implies that CM33 image should be signed by the keys generated. Refer to Section 4.2 for generating keys.
- The programFuse command can be added to change the board lifecycle to any after OEM-OPEN state (for example, ... 0x0F). In such as case, the flash of CM33 cannot be accessed via SWD, unless enable debug authentication is done as mentioned in <u>Section 6</u>.

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# 5.2 CM33 image preparation

Take SDK project <code>otac\_att</code> as example, set the <code>gEraseNVMLink\_d</code> linker symbol to 0 while generating the binary file.

If flash of NBU is empty, the Bluetooth Low Energy example code is stacked when initializing NBU. Also there would be an issue when Bluetooth Low Energy host stack is initialized. So, use a flag stored in a non-volatile memory to indicate whether to perform normal Bluetooth Low Energy process, or perform burn NBU image process. For the process described in this document, this flag stores a reserve variable in HWParameters as show in Figure 8.

```
static vold start_task(void "argument)

static vold start_task(void "argument)

static vold start_task(void "argument)

static vold start_task(void "argument)

static vold start_task(void "argument")

static vold start_task sportuct to start start start sportuct vold sportuct
```

## 5.2.1 Default OEM keys on KW45B41Z board

For the KW45B41Z-EVK board, NXP provides the default keys in fuse and these are shown in <u>Figure 9</u>. However, for the KW45 chip received from the factory, by default, the SBKDK and RoTKTH keys in the fuse are null. Therefore, writing these two keys to fuse is necessary as the sb3 update would fail without these two keys in fuse.

## 5.2.2 Writing OEM keys in application code by nboot API

KW45 ROM bootloader provides nboot API that can program the fuse. Follow the below steps to enable nboot API:

- 1. In the BLE example project, add the driver files fsl romapi.c and fsl nboot.h to the project.
- 2. Open fsl\_romapi.c, remove the API related to flash operation, otherwise duplicate definitions error would appear while compiling the project.

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3. In otap\_client\_att.c, add:

```
#include "fsl_nboot.h"
```

Then, define the SB3KDK and RoTKTH array as shown in Figure 9.

The function code shown in Figure 10 shows how to program the SBKDK and RoTKTH to the fuse:

```
#if TEST_UPDATE_NBU_FROM_APP_IN_SECURE_LIFECYCLE
                            int JiaTest_Set_LifeCycleAndKeys_Secure(uint8_t * pSB3KDK, uint8_t * pRoTKTH)
                                           static spc_active_mode_sys_ldo_option_t SysLdoOption;
                                         status_t TestSta;
uint32_t RegPrimask;
                                         uint8_t TestTempBuff[32] = {0};
                                         nboot_status_t TestSta1, TestSta2, TestSta3;
                                         PRINTF("\r\n----\r\n");
                                          /* When select System LDO voltage level to Over Drive voltage, The HVD of System LDO must be disabled. */
                                         SPC_EnableActiveModeSystemHighVoltageDetect(SPC0, false);
                                        */ Use PRINTF to wait for a while for SPC_EnableActiveModeSystemHighVoltageDetect complete operation */
PRINTF("\r\nSet SYS LDO VDD Regulator regulate to Over Drive Voltage(2.5V)\r\n");

/* Set SYS LDO VDD Regulator regulate to Over Drive Voltage(2.5V) */
SysLdoOption.SysLDOVoltage = kSPC_SysLDO_OverDriveVoltage;
SysLdoOption.SysLDODriveStrength = kSPC_SysLDO_NormalDriveStrength;

// SPC use default configuration, so we just set sys Ldo option

TatStream SPC_StatisticMedSystemIDDrawlateConfig(CDCO)

**SysLdoOption.SysLDODriveStrength**

TatStream SPC_SysLDODriveStrength**

TatStream S
                                         TestSta = SPC_SetActiveModeSystemLDORegulatorConfig(SPC0, &SysLdoOption);
                                          if(kStatus Success == TestSta)
                                                       /* Disabling the interrupts before making any ROM API call is suggested,
                                                                since API code does not deal with interrupts */
                                                     RegPrimask = DisableGlobalIRQ();
                                                             Set/read keys in fuse *
                                                     TestSta1 = NBOOT_ContextInit(&JiaTestContext);
TestSta2 = NBOOT_FuseProgram(&JiaTestContext, NBOOT_FUSEID_CUST_PROD_OEMFW_AUTH_PUK, (uint32_t *)pRoTKTH, 32);
                                                       TestSta2 = NBOOT_FuseRead(&JiaTestContext, NBOOT_FUSEID_CUST_PROD_OEMFW_AUTH_PUK, (uint32_t *)TestTempBuff, 32);
                                                            TestSta3 = NBOOT\_FUSERead(\&JiaTestContext, NBOOT\_FUSEID\_CUST\_PROD\_OEMFN\_ENC\_SK, (uint32\_t *)TestTempBuff, 32); TestSta3 = NBOOT\_FUSERead(\&JiaTestContext, NBOOT\_FUSEID\_CUST\_PROD\_OEMFN\_ENC\_SK, (uint32\_t *)TestTempBuff, 32); TestSta3 = NBOOT\_FUSERead(\&JiaTestContext, NBOOT\_FUSEID\_CUST\_PROD\_OEMFN\_ENC\_SK, (uint32\_t *)TestTempBuff, 32); TestSta3 = NBOOT\_FUSEID\_CUST\_PROD\_OEMFN\_ENC\_SK, (uint32\_t *)TestSta3 = NBOOT\_FUSEID\_CUST\_PROD\_OEMFN\_ENC\_SK, (uint32\_t *)TestSta3 = NBOOT\_FUSEID\_CUST\_PROD\_OEMFN\_ENC\_SK, (uint32\_t *)TestSta3 = NBOOT\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_CUST\_FUSEID\_C
                                                     TestSta3 = NBOOT_FuseProgram(&JiaTestContext, NBOOT_FUSEID_CUST_PROD_OEMFW_ENG_SK, (uint32_t *)pSB3KDK, 32);
                                                     NBOOT ContextFree(&JiaTestContext);
                                                       /* Enable the interrupts after rom api calls */
                                                     EnableGlobalIRQ(RegPrimask);
                                                       /* Set SYS LDO VDD Regulator regulate to Normal Voltage(1.8V) */
                                                     SystdoOption.SystDOVoltage = kSPC_SystDO_NormalVoltage;
SystdoOption.SystDODriveStrength = kSPC_SystDO_NormalDriveStrength;
                                                      TestSta = SPC_SetActiveModeSystemLDORegulatorConfig(SPC0, &SysLdoOption);
                                                      PRINTF("\r\n Set SYS LDO VDD Regulator to Normal Voltage(1.8V)\r\n"); \\ PRINTF("\r\n Set SY3 is %X, TestSta2 is %X, TestSta3 is %X \r\n", TestSta1, TestSta2, TestSta3); \\ for(uint8_t i=0; i < 32; i++) \\ 
                                                                  PRINTF("%X", TestTempBuff[i]);
                                                       SPC_EnableActiveModeSystemHighVoltageDetect(SPC0,true);
                                                     /* Use PRINTF to wait for a while for SPC complete operation */
                                                    PRINTF("\r\n-----
                                                                                                                    --- End test -----\r\n"):
                                        else
                                                   PRINTF("\r\n Failed sta is %d \r\n", TestSta);
                                        return 0:
Figure 10. Programming the fuse
```

The fuse programming steps are listed below:

- The SYS LDO VDD Regulator level needs to be regulated to Over Drive Voltage level (2.5 V) when trying to program the fuse. The default SYS LDO VDD Regulator level is regulated to normal voltage 1.8 V.
- The nboot API does not deal with any interrupts, so you should disable the interrupts before making any nboot API calls.

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- The fuse is a program-once region. Hence, if the key region in fuse already has some values, then fuse programming will fail except for the same keys.
- After fuse is programmed, enable the interrupts.
- The SYS LDO VDD can only operate at the over-drive voltage for a limited amount of time for the life of the chip. Therefore, after programming the fuse, set the SYS LDO VDD to normal voltage.

The program keys to fuse operation must be done prior to modifying the OTA update configurations mentioned in <u>Section 5.2.3</u>.

# 5.2.3 Updating OTA update configurations

KW45 Boot ROM has a firmware update feature that can be used for updating both CM33 and NBU firmware. For example, it indicates and provides metadata information for update to be performed in KW45 IFR0 OTACFG page. (Refer to OTA update configuration in *KW45 RM*). The target image is the NBU image prepared as mentioned in NBU image preparation. The NBU image is placed in the address 0x7A000 as shown in Figure 11.

```
void BluetoothLEHost_AppInit(void)
] {
                                                               /*Install callback for button*/
] #if (defined(gAppButtonCnt_c) && (gAppButtonCnt_c > 0))
                                                              ] #if TEST_UPDATE_NBU_FROM_APP_IN_SECURE_LIFECYCLE
    if(pTestHwParams->reserved[63] != 0XFF)
                                                                        BluetoothLEHost_SetGenericCallback(BluetoothLEHost_GenericCallback);
BluetoothLEHost_Init(BluetoothLEHost_Initialized);
                                                               ] #if TEST_UPDATE_NBU_FROM_APP_IN_SECURE_LIFECYCLE
                                                                         else
{
                                                                               int res = -1;
int st;
Otaloader_info_t loader_info;
res = PLATFORM_OtaclearBootFlags();
if(res == 0)
                                                                                      //OTA successful, OTA update configuration will be cleared
PRINTE("\\\nFirmware update sucessful.\\\\n\");
pTestHWParams->\reserved[63] = '5';
NV_writeHWParameters();
PRINTE("\\\\\nFirmset HWParameter->\reserved[63] as '5' as a flag, recover
the flag by long press button SW2\\\\\\n\");
HAL_RESETMCU();
                                                                                      PRINTF("\r\nTest for update nbu firmware, NBU firmware is null, start nbu firmware update.\r\n");
PRINTF("\r\nSet new image flag to IFR0 -> OTACFG\r\n");
                                                                                       /* Program Keys to fuse, this must before update NBU*/
JiaTest_Set_LifeCycleAndKeys_Secure(user_SB3KDK, user_ROTKTH);
                                                                                      loader_info.image_addr = 0x7000;  //this is sb3 file address that store in internal flash, align with 8Kb //The OTA SelectedFlash->base_offset is 0x70000, I also use it.  //fill sb3 file size
                                                                                      loader_info.image_sz = 197524; //
loader_info.pBitMap = NULL; //use_internal_flash
loader_info.sb_arch_in_ext_flash = false;
loader_info.spi_baudrate = 0;
                                                                                       st = PLATFORM_OtaUpdateBootFlags(&loader_info);
                                                                                      PRINTF("\r\nupdate OTACFG status is %d \r\n", st);
PRINTF("\r\nReset MCU \r\n");
                                                                                }
else if (res == 2)
{//OTA failed, OTA update configuration will be cleared
PRINTF("\r\nFirmware update failed.\r\n");
                                                                                       nknow OTA firmware update status
PRINTF("\r\nUnknow firmware update status\r\n");
Figure 11. Updating OTA update configuration
```

## 5.3 CM33 signed image generation (optional)

If lifecycle is changed to OEM secure world closed via command in .sb3 file generated earlier, that means after ROM boot processes .sb3 file, NBU image is burnt and lifecycle is also changed. Therefore, the application image should also be signed because secure boot feature is enabled in that lifecycle. If this step is not done, a command must be added to change the board lifecycle to an after OEM-OPEN state in the .sb3 file. In such a case, the signed image is not required.

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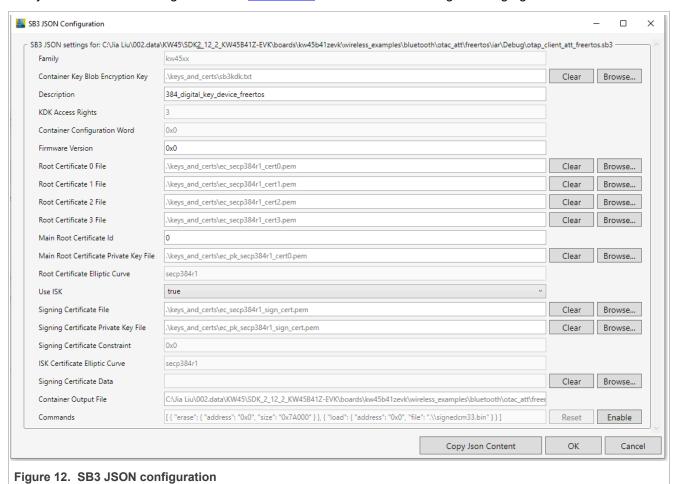
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#### Note:

The signed image feature is not provided in SPSDK for KW45 now. However, the signed image can be generated by using the Over The Air Programming tool. Follow the steps described in Bluetooth Low Energy Demo Applications User's Guide.pdf to generate the .sb3 file. Refer to the step show in Figure 12. The signed image can be found in the path below:

#### tool install path\Over The Air Programming 1.0.6.4\Secured\signedcm33.bin

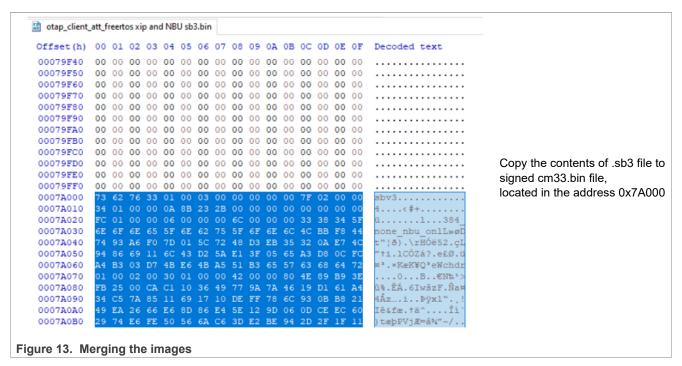
• Keys and Certificate files generated in Section 4.2" should be used for signed image generation.



# 5.4 Merging CM33 image and NBU image

Open the signed image file and .sb3 file using a Hex file editor tool. Copy the contents of .sb3 file to signedcm33.bin file, located in the address 0x7A000. Add a padding of 0x00 between the valid signedcm33.bin to 0x7A000 as shown in Figure 13.

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After merging CM33 image and NBU image, the merged image can be burnt to KW45 via SWD for mass production.

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# 6 Debug authentication

Debug authentication scheme is a challenge-response scheme and assures that only a debugger, which has possession of the required debug credentials can successfully authenticate over debug interface. Such a debugger can also access restricted parts of the device. The below sections describe steps for debug authentication.

## 6.1 Preparing keys and certificates for debug

Prior to generating debug credentials, it is necessary to generate an EC keypair (secp256r1 or secp384r1) for debugger known as Debug Credential Key (DCK).

The method of generating DCK is same as RoTKs generation in SPSDK Jupyter mentioned in <u>Section 4.2</u>, shown in <u>Figure 14</u>. Users can use the same code and change the file name of keypair. They can use the same syntax for generating the keypair.

## 6.2 Debugging credentials

In SPSDK virtual environment, use the syntax below for generating Configuration template:

```
nxpdebugmbox get-template -f C:\XXXX\...\XXXX\test.yml

Command Prompt

(venv) C:\Users\nxf41499>nxpdebugmbox get-template -f C:\jia\kw45_debug_auth\test\test1.yml
The configuration template file has been created.

(venv) C:\Users\nxf41499>

Figure 15. Configuration template generation
```

Open the Configuration template file and modify the content accordingly. For details, refer to the comment mentioned in the Configuration template file.

```
socc: 0x0005
uuid: "0000000000000000000000000000000000
cc_socu: 0xFFFF
cc_vu: 0
cc_beacon: 0
rot_meta: path of RoTKs public part, should same as keys used by .sb3
generation(e.g.. ./secp384r1_private_key0.pub)
rot_id: 0
```

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```
dck: path of public part of the DCK(e.g.. ./secp384r1_private_dck.pub)
rotk: path of RoTK private part for the rot_meta chosen by rot_id, should be the
  same as keys
used by .sb3 generation (e.g.. ./secp384r1_private_key0.pem)
socc: 0x0005
```

Use the syntax shown below for Debug Credential generation by using Configuration template:

```
nxpdebugmbox -p 2.1 gendc -c C: \XXXX\...\XXXX\test1.yml C: \YYYY\...\YYYY
\test.cert1
```

```
\(\text{(venv) C:\Users\nxf41499\nxpdebugmbox -p 2.1 gendc -c C:\jia\kw45_debug_auth\test\test1.yml C:\jia\kw45_debug_auth\test\\
test.cert1
RoT Key Hash: 650d8097079ff27a3e8a2da14781b922fd8295b6c00bfa067f00e87f1a16b8b304bf710d45cbd591e2e24be83183922c
Creating Debug credential file succeeded

Figure 16. Debug credential generation
```

# 6.3 Initiating debug authentication

1. In the virtual environment, start NXP debug box tool by using the command: *nxpdebugmbox start*. Refer <u>Figure 17</u>. Then, select J-Link as the debug probe.

```
(venv) C:\Users\nxf41499>nxpdebugmbox start

# Interface Id Description

O PyOCD 1064975848 Segger J-Link MCU-Link

1 Jlink 1064975848 Segger J-Link MCU-Link: 1064975848

Please choose the debug probe: 1
Start Debug Mailbox succeeded

(venv) C:\Users\nxf41499>_
```

Figure 17. Initiating debug using the 'nxpdebugmbox start' command

2. Use the command below to initiate debug authentication (refer Figure 18):

```
\label{link} $$  \nxpdebugmbox -v -p 2.1 -i jlink auth -b 0x0 -c C: \YYYYY\...\YYYYY test.cert -k C:\ZZZZ\....\ZZZZ\secp384r1\_private\_dck.pem
```

C:\ZZZZ\...\ZZZZ\secp384r1\_private\_dck.pem is the private key generated using the steps described in Section 6.1.

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```
(venv) C:\Users\nxf41499>nxpdebugmbox -v -p 2.1 -i jlink auth -b 0x0 -c C:\jia\kw45_debug_auth\test\test.cert -k
C:\jia\kw45_debug_auth\test\secp384r1_private_dck.pem
INFO:spsdk.apps.nxpdebugmbox:Starting Debug Authentication
# Interface Id Description
    INFO:spsdk. apps. nxpdebugmbox:DAC:
                                   : 2.1
: 5, KW45xx/K32W1xx
: DA39A0723338B23DBFB5ED282A20DEC9
    Version
    SOCC
   SOCC
UUID
CC_VU
ROTID_rkh_revocation
ROTID_rkth_hash
SC_soc_ninned
                                     650d8097079ff27a3e8a2da14781b922fd8295b6c00bfa067f00e87f1a16b8b3
    CC_soc_pinned
CC_soc_default
                                   : 00000000
                                   : 9a8306a884104efefbf7c4516aeabe7c6ebd60b5cf68455cfbac64be708cd8cb
    Challenge
    INFO:spsdk.apps.nxpdebugmbox:DAR:
                                   : 2.1
: 5, KW45xx/K32W1xx
: DA39A0723338B23DBFB5ED282A20DEC9
    Version
    SOCC
    UUID
    CC_VU
ROTID_rkh_revocation
ROTID_rkth_hash
                                   : 00000000
                                     650d8097079ff27a3e8a2da14781b922fd8295b6c00bfa067f00e87f1a16b8b3
    ROID_IRTH_Hash
CC_soc_pinned
CC_soc_default
                                   : 00000000
                                     00000000
                                     9a8306a884104efefbf7c4516aeabe7c6ebd60b5cf68455cfbac64be708cd8cb
    Challenge
    DC:
    CC_SOCC : 0x7f
CC_VU : 0x0
BEACON : 0
    CRTK table has 4 entries
CRTK table has 4 entries
CRTK Hash: 650d8097079ff27a3e8a2da14781b922fd8295b6c00bfa067f00e87f1a16b8b304bf710d45cbd591e2e24be83183922c
    Authentication Beacon: 0
    INFO:spsdk.apps.nxpdebugmbox:Debug Authentication ends successfully.
Figure 18. Debug authentication
```

#### Starting debug

After debug authentication ends successfully, the device enables access to the debug domains permitted in the DC. Do not reset KW45, use J-Link Commander to connect to the device directly. The log is shown in Figure 19.

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#### Note:

Access is disabled when KW45 is reset. Therefore, if KW45 is reset, debug authentication should be done again. This implies that the user should not use IDE to debug since reset KW45 operation may be embedded in IDE.

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# 7 Acronyms and abbreviations

The table below lists the acronyms used in this document.

Table 1. Acronyms and abbreviations

S.No	Acronym	Description
1	AES	Advanced Encryption Standard
2	Bluetooth LE	Bluetooth Low Energy
3	DCK	Debug Credential Key
4	IDE	Integrated Design Environment
5	ISP	In-System Programming
6	NBU	Narrow Band Unit
7	OEM	Original Equipment Manufacturer
8	RoTKTH	Root of Trust Key Table Hash
9	SB3KDK	SB3 Key Derivation Key
10	SDK	Software Development Kit
11	SPSDK	Secure Provisioning SDK
12	SWD	Serial Wire Debug
13	XIP	Execute-In-Place

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# 8 References

Refer to the below documents for more information:

- Managing Lifecycles on KW45 and K32W148 (AN13931)
- Secure Boot for KW45 and K32W (AN13838)
- KW45 Reference Manual (KW45RM)
- Bluetooth Low Energy Demo Applications User's Guide.pdf. This document can be downloaded from the KW45 SDK available on the NXP website. Alternatively, contact the NXP field applications engineer (FAE) for obtaining this document.

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# 9 Revision history

Table 2 summarizes the revisions to this document.

# **Document revision history**

Revision history				
Revision number	Release date	Description		
1.0	16 August 2023	Initial public release		

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